Application/Control No. Applicant(s)/Patent Under Reexamination WATANABE ET AL. Examiner Paul R. Myers Applicant(s)/Patent Under Reexamination WATANABE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,285,746	09-2001	Duran et al.	379/93.21
	В	US-6,263,022	07-2001	Chen et al.	375/240.03
	С	US-6,526,462	02-2003	Elabd, Hammam	710/242
:	D	US-4,271,518	06-1981	Birzele et al.	714/781
	E	US-			
	F	US-			
	G	US-			
	ı	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	· · · · · · · · · · · · · · · · · · ·							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N	JP 11032332 A	02-1999	Japan	WU et al.	H04N 07/24		
	0							
	Р							
	Q							
	R							
	s							
	т							

NON-PATENT DOCUMENTS

NON-FATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
<u> </u>	V							
	w							
	×							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.